

Method for testing the authenticity of a data carrier**Publication number:** JP9501529T**Publication date:** 1997-02-10**Inventor:****Applicant:****Classification:****- International:** G06K7/00; G07F7/10; G06K7/00; G07F7/10; (IPC1-7):
G06K19/07; G06K17/00; G06K19/10**- european:** G06K7/00E; G07F7/10D4E2**Application number:** JP19950500346T 19950602**Priority number(s):** DE19944419805 19940606; WO1995EP02104
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PCT No. PCT/EP95/02104 Sec. 371 Date Jul. 15, 1996 Sec. 102(e) Date Jul. 15, 1996 PCT Filed Jun. 2, 1995 PCT Pub. No. WO95/34054 PCT Pub. Date Dec. 14, 1995A method for testing the authenticity of a data carrier having at least an integrated circuit with memory units and logic units as well as a data line for data exchange with an external device. The invention is characterized in that the integrated circuit additionally has a separate hard-wired circuit for transmitting and/or receiving data during the power-up sequence, which is used for authenticity testing, the first transmission or reception of data being completed within a defined time domain of the power-up sequence in which the data line has no defined state.

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